

<b><i>N t i c   o f   R   e r e n c e s   C i t e d</i></b>	Application/Control No. 09/715,081	Applicant(s)/Patent Under Reexamination NAKAYAMA ET AL.	
	Examiner Jeffrey A. Shapiro	Art Unit 3653	Page 1 of 1

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**NON-PATENT DOCUMENTS**

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